

INTERNATIONAL STANDARD

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**Transmitters for use in industrial-process control systems –
Part 2: Methods for inspection and routine testing**
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**Transmetteurs utilisés dans les systèmes de conduite des processus
industriels –**
<https://standards.iteh.ai/catalog/standards/sist/acde0891-cadd-4301-bf06-389e-389e-389e-389e>
Partie 2: Méthodes pour l'inspection et les essais individuels de série



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**TRANSMITTERS FOR USE IN INDUSTRIAL-PROCESS
CONTROL SYSTEMS –****Part 2: Methods for inspection and routine testing**

FOREWORD

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International Standard IEC 60770-2 has been prepared by subcommittee 65B: Devices & process analysis, of IEC technical committee 65: Industrial-process measurement, control and automation.

This third edition cancels and replaces the second edition published in 2003. This edition constitutes a technical revision.

The significant technical change with respect to the previous edition is as follows:

- The sequence in content has been reordered in Clause 5.

This standard should be read in conjunction with IEC 61298-1, IEC 61298-2, IEC 61298-3 and IEC 61298-4.

The text of this standard is based on the following documents:

FDIS	Report on voting
65B/760/FDIS	65B/773/RVD

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all parts of IEC 60770 series, under the general title *Transmitters for use in industrial-process control systems*, can be found on the IEC website.

The committee has decided that the contents of this publication will remain unchanged until the stability date indicated on the IEC web site under "http://webstore.iec.ch" in the data related to the specific publication. At this date, the publication will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

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INTRODUCTION

The methods of inspection and routine testing specified in this standard are intended for use in acceptance tests or after repair to verify the fulfilment of the performance specifications as established by the user. The methods given in this standard are primarily intended for the testing of conventional analogue transmitters. For setting up test procedures for microprocessor-based instruments IEC 60770-3 and IEC/TS 62098 should be consulted.

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TRANSMITTERS FOR USE IN INDUSTRIAL-PROCESS CONTROL SYSTEMS –

Part 2: Methods for inspection and routine testing

1 Scope and object

This part of IEC 60770 is applicable to transmitters, which have either a standard analogue electric current output signal or a standard pneumatic output analogue signal in accordance with IEC 60381-1 or IEC 60382. The tests detailed herein may be applied to transmitters which have other output signals, provided that due allowance is made for such differences.

For the method of inspection and routine testing of the intelligent transmitters see IEC 60770-3.

For certain types of transmitters, where the sensor is an integral part, other specific IEC or ISO standards may need to be consulted (e.g. for chemical analyzers, flow-meters, etc.)

This standard is intended to provide technical methods for inspection and routine testing of transmitters, for instance, for acceptance tests or after repair. For a full evaluation, IEC 60770-1 and/or IEC 60770-3, respectively for analogue or intelligent transmitters shall be used.

Quantitative criteria for acceptable performance should be established by agreement between manufacturer and user.

By agreement the tests need not be carried out by an accredited laboratory.

2 Normative references

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60050-300, *International Electrotechnical Vocabulary – Electrical and electronic measurements and measuring instruments – Part 311: General terms relating to measurements – Part 312: General terms relating to electrical measurements – Part 313: Types of electrical measuring instruments – Part 314: Specific terms according to the type of instrument*

IEC 60381-1:1982, *Analogue signals for process control systems – Part 1: Direct current signals*

IEC 60382:1991, *Analogue pneumatic signal for process control systems*

IEC 60410:1973, *Sampling plans and procedures for inspection by attributes*

IEC 60770-1:1999, *Transmitters for use in industrial-process control systems – Part 1: Methods for performance evaluation*

IEC 60770-3:2006, *Transmitters for use in industrial-process control systems – Part 3: Methods for performance evaluation of intelligent transmitters*

IEC 61298-1:2008, *Process measurement and control devices. – General methods and procedures for evaluating performance – Part 1: General considerations*

IEC 61298-2:2008, *Process measurement and control devices – General methods and procedures for evaluation performance – Part 2: Tests under reference conditions*

IEC 61298-3:2008, *Process measurement and control devices – General methods and procedures for evaluating performance – Part 3: Tests for the effects of influence quantities*

IEC 61298-4:2008, *Process measurement and control devices – General methods and procedures for evaluating performance – Part 4: Evaluation report content*

IEC/TS 62098:2000, *Evaluation methods for microprocessor-based instruments*

3 Terms and definitions

For the purposes of this document, the terms and definitions given in IEC 60050-300, in the IEC 61298 series and the following apply.

3.1 acceptance test

test proving to the user that the device complies with the performance specifications as they appear in the contract

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3.2 variable

quantity or condition whose value is subject to change and can usually be measured

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EXAMPLE temperature, flow rate, speed, signal, etc.

3.3 signal

physical variable of which one or more parameters carry information about one or more variables represented by the signal

3.4 range

region of the values between the lower and upper limits of the quantity under consideration

3.5 span

algebraic difference between the upper and lower limit values of a given range

3.6 test procedure

statement of the tests to be carried out and the conditions for each test, agreed between the manufacturer, the test laboratory and the purchaser/user before the evaluation starts

3.7 maximum measured error

largest positive or negative value of error of the upscale or downscale value of each point of measurement

3.8**hysteresis**

greatest difference between the upscale and downscale output readings at one point

3.9**step response**

time response of a transmitter produced by a stepwise variation of one of the input variables

3.10**influence quantity**

parameter chosen to represent one aspect of the environment under which a device may operate

4 Sampling for test

If, by agreement between user and manufacturer, tests are to be performed only on samples, it is recommended that a sampling method such as that presented in IEC 60410 be selected. When sampling is used, transmitters to be tested may be chosen by the user.

5 Performance tests**5.1 General**

The tests listed in 5.5 and 5.6 shall be performed. Under certain circumstances, the user may not require every test to be carried out. The sequence of the tests shall be such that the results of a test are not affected by a previous test, provided proper pre-conditioning has been performed.

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5.2 Test conditions**5.2.1 Ambient conditions**

- Temperature from 15 °C to 25 °C
- Relative humidity from 45 % to 75 %
- Atmospheric pressure from 86 kPa to 106 kPa
- Electromagnetic field value to be stated if relevant

The maximum rate of change of ambient temperature permissible during any test shall be 1 °C in 10 min, but not more than 3 °C per hour.

5.2.2 Supply conditions

Electrical supply:

- rated voltage ± 1 %
- rated frequency ± 1 %
- harmonic distortion (a.c. supply) less than 5 %
- ripple (d.c. supply) less than 0,1 %

Pneumatic supply:

- rated pressure ± 3 %
- supply air temperature ambient temperature ± 2 °C

- supply air humidity dew-point at least 10 °C below device body temperature
- oil and dust content oil: less than 1×10^{-6} by weight
dust: absence of particles greater than 3 μm

5.2.3 Load conditions

Electrical instrumentation:

- voltage output signals: the minimum load value specified by the manufacturer
- current output signals: the maximum load value specified by the manufacturer

Pneumatic instrumentation:

- a rigid tube 8 m long and 4 mm internal diameter connected to a 20 cm³ rigid container.

5.3 Preconditioning

For preconditioning with power applied to the transmitter, sufficient time (not less than 30 min) should be allowed to ensure stabilization of the operating temperature of the transmitter.

5.4 Adjustments

The routine tests shall be carried out (as an acceptance test or after repair) with the adjustments for lower range value, span and damping determined by the user in consultation with the manufacturer.

5.5 Tests under reference conditions

5.5.1 Measured error and hysteresis

The input-output characteristic under reference conditions shall be measured in one measurement cycle, traversing the full range in each direction. For this, at least five points of measurement should be evenly distributed over the range; they should include points at or near (within 10 % of span) the 0 % and 100 % values of the span.

NOTE For instruments with a non-linear input-output relationship (e.g. square law), the test points should be chosen so as to obtain output values equally distributed over the output span.

Measurement procedure:

Initially, an input signal equal to the lower range value is generated and the value of the corresponding input and output signal is noted. Then the input signal is slowly increased to reach, without overshoot, the first test point. After an adequate stabilization period, the value of the corresponding input and output signal is noted.

The operation is repeated for all the predetermined values up to 100 % of the input span. After measurement at this point, the input signal is slowly brought down, without overshoot, to the test value directly below 100 % of input span, and then to all other values in turn down to 0 % of input span, thus closing the measurement cycle.

The difference between the output signal values obtained at the test points for each upscale and downscale traverse and the corresponding ideal values are recorded as the measured errors. The errors generally shall be expressed as percent of the ideal output span. All the error values thus obtained shall be shown in a tabular form (see Table 1) and presented graphically (see Figure 1).

Table 1 – Typical measured errors

Output (% of span)	0	20	40	60	80	100
Measured error up		0,09	-0,04	-0,23	-0,22	0,10
Measured error down	-0,06	0,26	0,17	-0,08	-0,13	
Maximum measured error	-0,06	0,26	0,17	-0,23	-0,22	0,10
Hysteresis		0,17	0,21	0,15	0,09	

From Table 1, the maximum measured error found is 0,26 % and the maximum hysteresis is 0,21 %. The data from Table 1 are plotted in Figure 1.

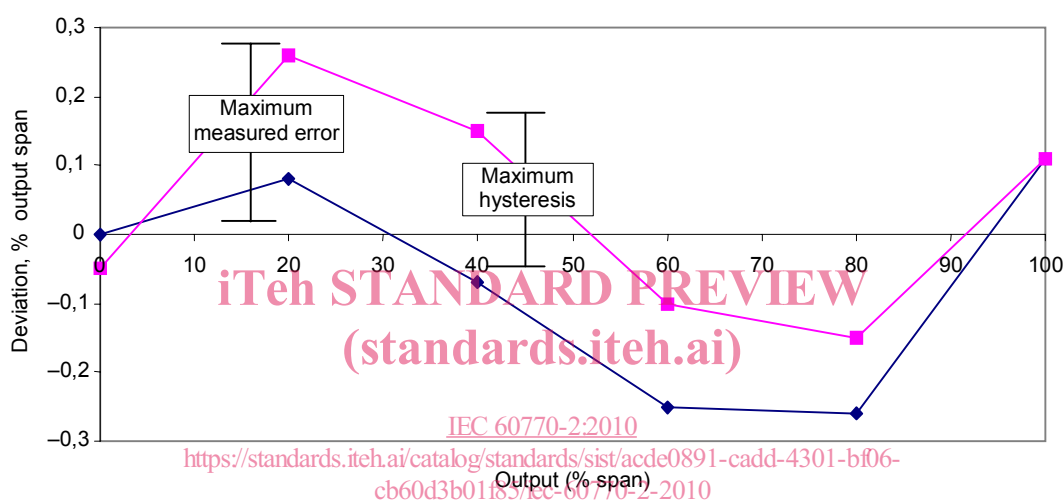


Figure 1 – Typical measured error plot

5.5.2 Step response

Output loading:

Electrical transmitters: Values specified by the manufacturer or a 0,1 μF capacitor in parallel with the reference load resistance.

Pneumatic transmitters: An 8 m length of 4 mm internal diameter rigid pipe connected to a 20 cm³ rigid container.

Measurement procedure:

Two steps corresponding to 80 % of output span, preferably from 10 % to 90 %, then from 90 % to 10 % shall be applied.

The settling time, the time for the output to reach and remain within 1 % of the span of its steady state value shall be reported for each step. The amount of dead time, rise time, time constant and overshoot (in percentage of span), if any, shall also be reported. Figure 2 illustrates the definitions of the times and gives examples of responses to a positive step input.

NOTE If there is difficulty in generating or recording an accurate input step, due to the physical characteristics or range of the input variable, the dynamics required for this test should be agreed between the manufacturer and the user. Where there is no concern about the step response, this test may be omitted.